Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.			SERIAL N		
(Modified)		PATENT AND TRADE	EMARK OFFICE	285995US26PCT			10/567,733		
				APPLICANT					
LIST OF	REFEF	RENCES CITED BY APF	PLICANT	Kohei KAWAMURA, et al.					
				FILING DATE			GROUP		
				February 10, 2006			2812		
			l.	U.S. PATENT DOCUMENTS			-		
EXAMINER INITIAL		DOCUMENT NUMBER	DATE			CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
	AA	US 2003/0025209 A1	2/6/2003	Nobuhiro JIWARI, et al.		<u> </u>	<u> </u>		
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		DOCUMENT NUMBER	DATE	COUNTR	RY		YES	TRANSL S	LATION NO
<del></del>	AO	EP 1 035 568 A1	9/13/2000	Europe					
	AP	EP 1 077 846 A1	2/21/2001	Europe					
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		OTHER RE	FERENCES	(Including Author, Title, Date	e, Pertinent	t Pages, e	tc.)		
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	AZ Additional						itional Refe	erences s	sheet(s) attached
Examiner	1	1				Date Co	onsidered		
*Evaminer: li	nitial if	reference is considered.	whether or no	ot citation is in conformance wi	ith MPEP 6	09; Draw li	ine through	n citation	if not in
conformance	e and n	ot considered. Include c	opy of this for	m with next communication to	applicant.				